

MOS FIELD EFFECT TRANSISTOR 2SJ625

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The 2SJ625 is a switching device which can be driven directly by a 1.8 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 1.8 V drive available
- Low on-state resistance $R_{DS(on)1} = 113 \text{ m}\Omega \text{ MAX.}$ (VGs = -4.5 V, ID = -1.5 A) $R_{DS(on)2} = 171 \text{ m}\Omega \text{ MAX.}$ (VGs = -2.5 V, ID = -1.5 A) $R_{DS(on)3} = 314 \text{ m}\Omega \text{ MAX.}$ (VGs = -1.8 V, ID = -1.0 A)

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SJ625	SC-96 (Mini Mold Thin Type)

Marking: XM

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	-20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓8.0	V
Drain Current (DC) (T _A = 25°C)	ID(DC)	∓3.0	Α
Drain Current (pulse) Note1	D(pulse)	∓12	Α
Total Power Dissipation	P T1	0.2	W
Total Power Dissipation Note2	P T2	1.25	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

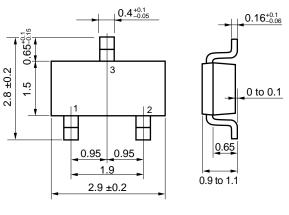
Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board, $t \le 5$ sec.

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

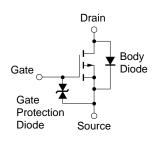
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PACKAGE DRAWING (Unit: mm)



1 : Gate 2 : Source 3 : Drain

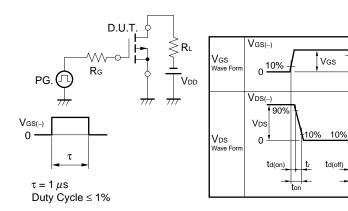
EQUIVALENT CIRCUIT



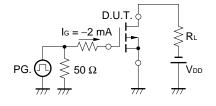
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -20 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 8.0 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			∓10	μA
Gate Cut-off Voltage	VGS(off)	$V_{DS} = -10 \text{ V}, \text{ ID} = -1.0 \text{ mA}$	-0.45	-0.75	-1.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = -10 V, I _D = -1.5 A	2.0	4.9		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$		90	113	mΩ
	RDS(on)2	$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$		128	171	mΩ
	RDS(on)3	$V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -1.0 \text{ A}$		188	314	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		348		pF
Output Capacitance	Coss	V _{GS} = 0 V		88		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		38		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 \text{ V}, \text{ ID} = -1.5 \text{ A}$		39		ns
Rise Time	tr	$V_{GS} = -4.0 V$		190		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		220		ns
Fall Time	tr			250		ns
Total Gate Charge	QG	V _{DD} = -16 V		2.6		nC
Gate to Source Charge	Q _{GS}	V _{GS} = -4.0 V		0.8		nC
Gate to Drain Charge	Qgd	ID = -3.0 A		0.9		nC
Body Diode Forward Voltage	VF(S-D)	IF = 3.0 A, VGS = 0 V		0.89		V

TEST CIRCUIT 1 SWITCHING TIME



TEST CIRCUIT 2 GATE CHARGE



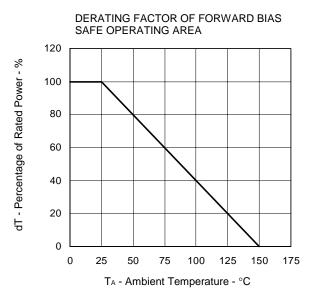
90%

90%

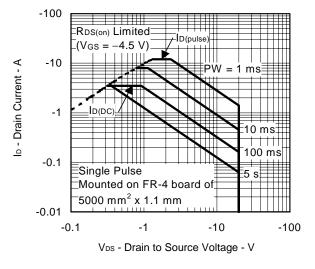
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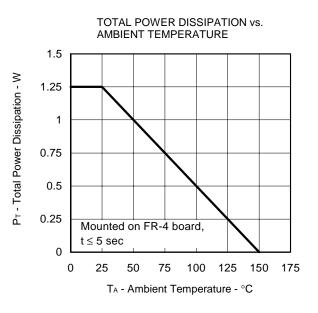
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TYPICAL CHARACTERISTICS (TA = 25°C)

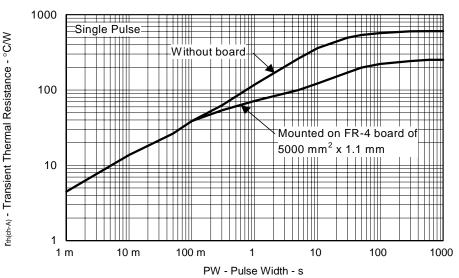






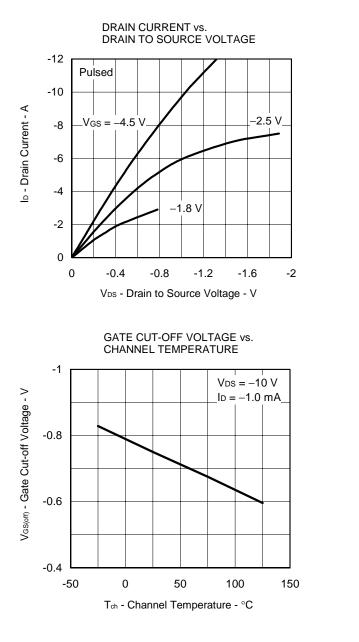


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

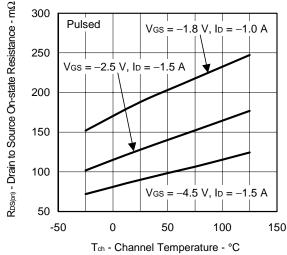


Data Sheet D15961EJ1V0DS

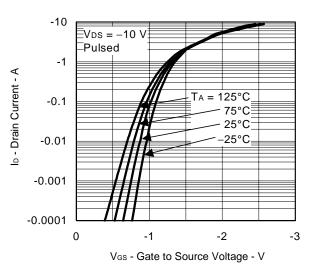
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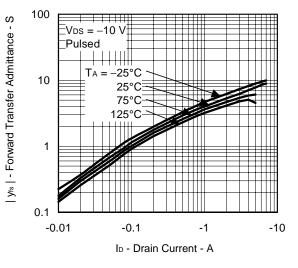




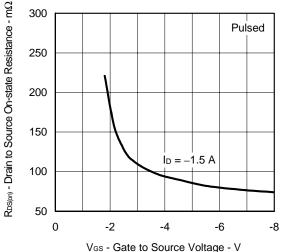


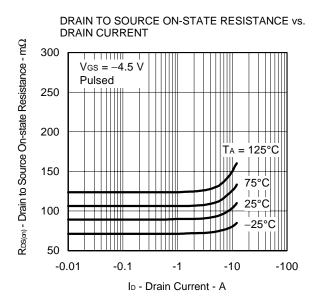


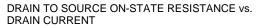
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

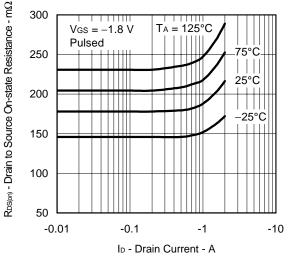


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

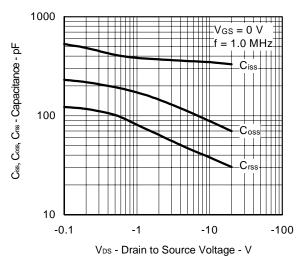




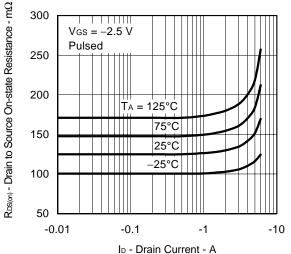




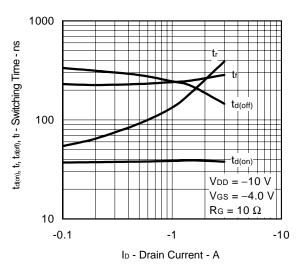
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



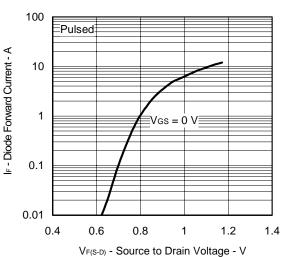
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



SWITCHING CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



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[MEMO]

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